LL4151

Small Signal Diodes

MiniMELF

Cathode Mark | Color | Color

Dimensions in inches and (millimeters)

FEATURES

- Silicon Epitaxial Planar Diode
- Fast switching diode in MiniMELF case especially suited for automatic insertion.
- This diode is also available in other case styles including the DO-35 case with the type designation 1N4151 and the SOD-123 case with the type designation 1N4151W.

MECHANICAL DATA

Case: MiniMELF Glass Case (SOD-80)

Weight: approx. 0.05 g

MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Ratings at 25 °C ambient temperature unless otherwise specified

	Symbol	Value	Unit	
Reverse Voltage	V _R	50	V	
Peak Reverse Voltage	V _{RM}	75	V	
Forward DC current at T _{amb} = 25 °C	I _F	2001)	mA	
Rectified Current (Average) Half Wave Rectification with Resist. Load at T_{amb} = 25 °C and f \geq 50 Hz	10	150 ¹⁾	mA	
Surge Forward Current at t < 1 s and T _j = 25 °C	I _{FSM}	500	mA	
Power Dissipation at T _{amb} = 25 °C	P _{tot}	500 ¹⁾	mW	
Junction Temperature	Tj	175	°C	
Storage Temperature Range	T _S	-65 to +175	°C	





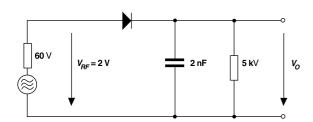
LL4151

ELECTRICAL CHARACTERISTICS

Ratings at 25 °C ambient temperature unless otherwise specified

	Symbol	Min.	Тур.	Max.	Unit
Forward Voltage at I _F = mA	V _F	_	_	1	V
Leakage Current at $V_R = 50 \text{ V}$ at $V_R = 50 \text{ V}$, $T_j = 150 \text{ °C}$	I _R	_ _	- -	50 50	nA μA
Capacitance at $V_F = V_R = 0$	C _{tot}	_	_	2	pF
Reverse Recovery Time from I_F = 10 mA through I_R = 10 mA to I_R = 1 mA from I_F = 10 mA to I_R = 1 mA, V_R = 6 V, R_L = 100 Ω	t _{rr}	_ _	- -	4 2	ns ns
Thermal Resistance Junction to Ambient Air	R _{thJA}	_	_	0.351)	K/mW
Rectification Efficiency at f = 100 MHz, V _{RF} = 2 V	η_{V}	0.45	_	_	_

¹⁾ Valid provided that electrodes are kept at ambient temperature.

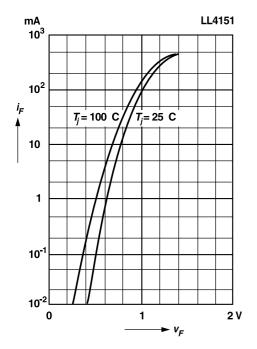


Rectification Efficiency Measurement Circuit



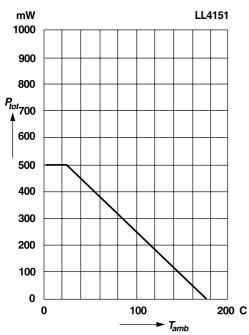
RATINGS AND CHARACTERISTIC CURVES LL4151

Forward characteristics

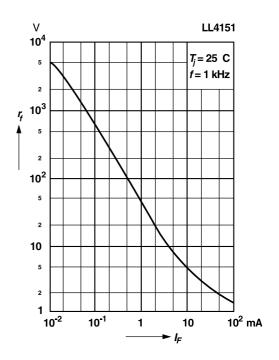


Admissible power dissipation versus ambient temperature

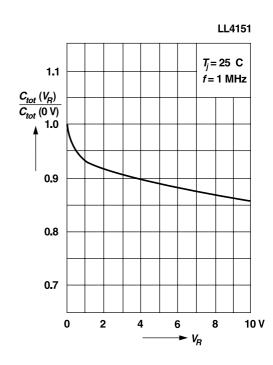
Valid provided that electrodes are kept at ambient temperature



Dynamic forward resistance versus forward current



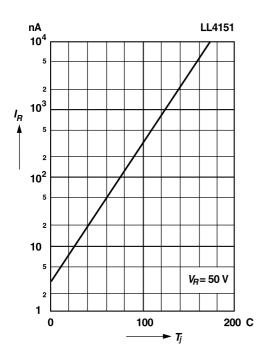
Relative capacitance versus reverse voltage





RATINGS AND CHARACTERISTIC CURVES LL4151

Leakage current versus junction temperature



Admissible repetitive peak forward current versus pulse duration

Valid provided that electrodes are kept at ambient temperature

